

FDMC8200-VB Datasheet Dual N-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)
30	$0.009 \text{at V}_{\text{GS}} = 10 \text{V}$	35	15 nC
30	0.016at V _{GS} = 4.5 V	30	10 110

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % UIS Tested
- 100 % R_q Tested
- Compliant to RoHS Directive 2002/95/EC

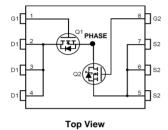


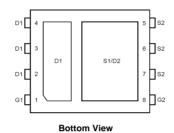
HALOGEN FREE

DFN 3*3

APPLICATIONS

- Set Top Box
- Low Current DC/DC





ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, Parameter Drain-Source Voltage Gate-Source Voltage		Symbol	Limit	Unit
		V _{DS}	30 ± 20	
		V _{GS}		
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I _D	35 ^a 24 17.5 ^{b, c} 15.5 ^{b, c}	A
Pulsed Drain Current		I _{DM}	105	^
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I _S	2.25 1.48 ^{b, c}	
Single Pulse Avalanche Current		I _{AS}	5	
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	1.25	mJ
Maximum Power Dissipation	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	P _D	56 15 2.18 ^{b, c} 1.34 ^{b, c}	W
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C

THERMAL RESISTANCE RAT	INGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, c, d}	t ≤ 10 s	R _{thJA}	58	70	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	38	45	C/ VV

Notes:

- a. Package limited, $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 110 °C/W.



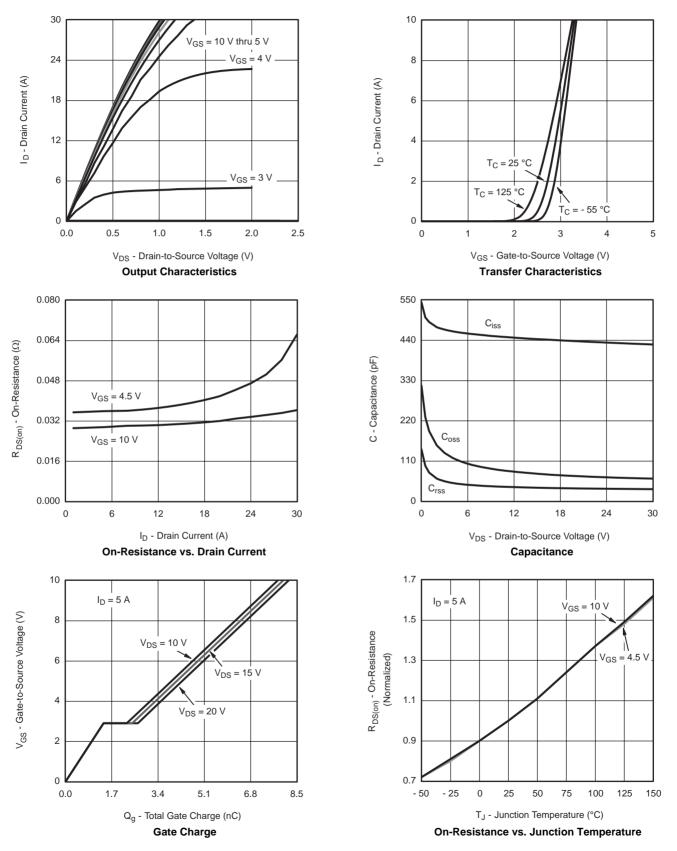
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 HA		32		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	$I_{D} = 250 \mu A$		- 5.0		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.0		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7 0	1 .	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	10			Α
		V _{GS} = 10 V, I _D = 5 A		0.009		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V, I}_{D} = 4 \text{ A}$		0.016		Ω
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 5 A		16	1	S
Dynamic ^b	1 -,0			l		
Input Capacitance	C _{iss}			900		
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		257		pF
Reverse Transfer Capacitance	C _{rss}			155		
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		15		
Total Gate Charge	Qg			3.7	5.6	_
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		1.4		nC
Gate-Drain Charge	Q _{gd}			1.05		1
Gate Resistance	R _g	f = 1 MHz	0.8	4.3	8.6	Ω
Turn-On Delay Time	t _{d(on)}			12	24	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		55	100	1
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		11	22	1
Fall Time	t _f	$V_{DD} = 15 \text{ V, } R_{L} = 3 \Omega$		8	16	1
Turn-On Delay Time	t _{d(on)}			4	8	ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 3 \Omega$		9	18	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		10	20	
Fall Time	t _f			6	12	1
Drain-Source Body Diode Characteristic			I			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			35	
Pulse Diode Forward Current	I _{SM}				105	A
Body Diode Voltage	V _{SD}	I _S = 2 A, V _{GS} = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			11	20	ns
Body Diode Reverse Recovery Charge	Q _{rr}			4	8	nC
Reverse Recovery Fall Time	+ -	I_{SM} $I_{S} = 2 \text{ A}, V_{GS} = 0 \text{ V}$ I_{fr}		7		
Reverse Recovery Rise Time	t _b			4		ns

Notes:

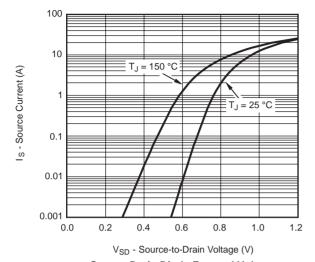
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

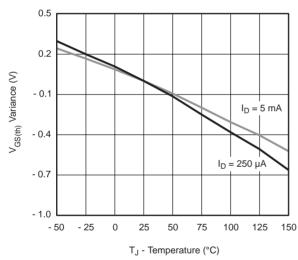




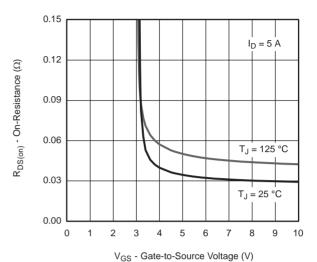




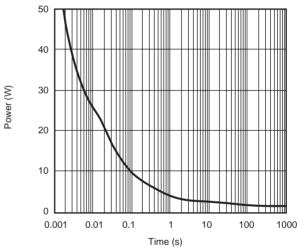
Source-Drain Diode Forward Voltage



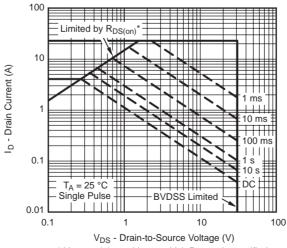
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



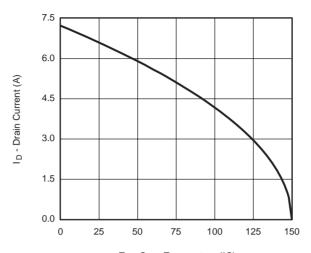
Single Pulse Power



* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

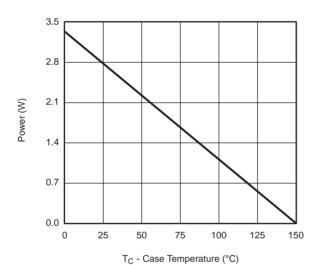
Safe Operating Area, Junction-to-Ambient

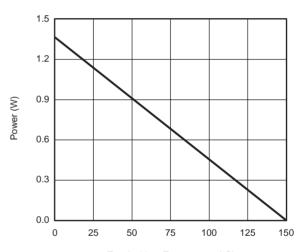




T_C - Case Temperature (°C)

Current Derating*





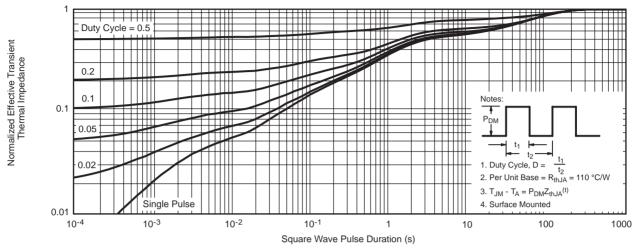
T_A - Ambient Temperature (°C)

Power, Junction-to-Foot

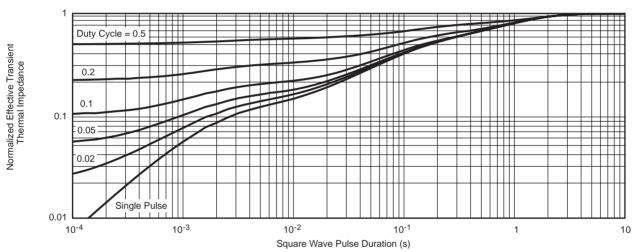
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





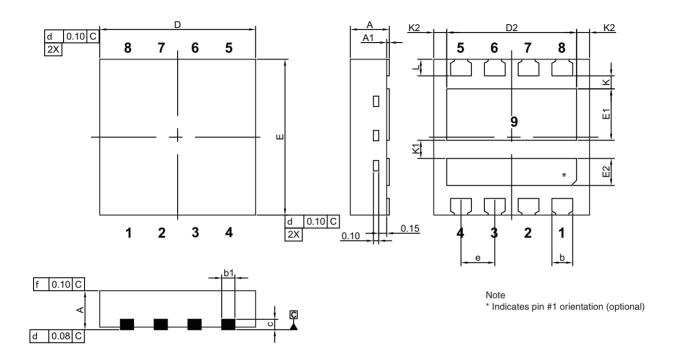
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



PowerPAIR® 3 x 3 Case Outline

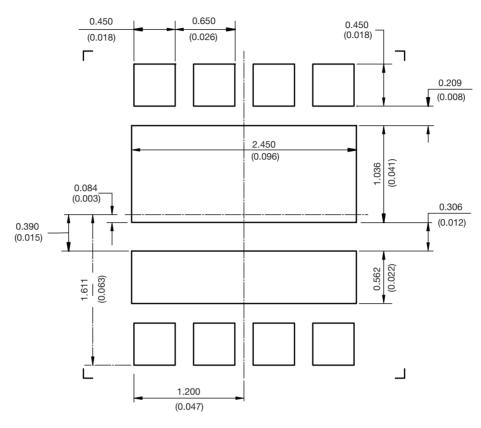


		MILLIMETERS			INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.35	0.40	0.45	0.014	0.016	0.018	
b1	0.20	0.25	0.38	0.008	0.010	0.015	
С	0.18	0.20	0.23	0.007	0.008	0.009	
D	2.90	3.00	3.10	0.114	0.118	0.122	
D2	2.35	2.40	2.45	0.093	0.094	0.096	
E	2.90	3.00	3.10	0.114	0.118	0.122	
E1	0.94	0.99	1.04	0.037	0.039	0.041	
E2	0.47	0.52	0.57	0.019	0.020	0.022	
е	0.65 BSC			0.026 BSC			
K	0.25 typ.			0.010 typ.			
K1	0.35 typ.			0.014 typ.			
K2	0.30 typ.			0.012 typ.			
L	0.27	0.32	0.37	0.011	0.013	0.015	

DWG: 5998



RECOMMENDED MINIMUM PAD FOR PowerPAIR® 3 x 3



Recommended PAD for PowerPAIR 3 x 3

Dimensions in millimeters (inches)

Keep-Out 3.5 mm x 3.5 mm for non terminating traces



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